TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSIII)

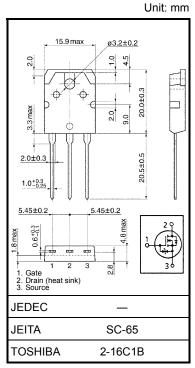
2SK2719

Chopper Regulator, DC-DC Converter and Motor Drive Applications

- Low drain-source ON resistance: RDS (ON) = 3.7Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 2.6 \text{ S (typ.)}$
- Low leakage current: IDSS = 100 μA (max) (VDS = 720 V)
- Enhancement mode: $V_{th} = 2.0 \sim 4.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	900	V	
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V_{DGR}	900	V	
Gate-source voltage		V _{GSS}	±30	V	
Drain current	DC (Note 1)	Ι _D	3	А	
	Pulse (Note 1)	I _{DP}	9		
Drain power dissipation	(Tc = 25°C)	P _D	125	W	
Single pulse avalanche energy (Note 2)		E _{AS}	295	mJ	
Avalanche current		I _{AR}	3	Α	
Repetitive avalanche energy (Note 3)		E _{AR}	12.5	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	



Weight: 4.6 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	1.0	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	50.0	°C/W

- Note 1: Ensure that the channel temperature does not exceed 150°C.
- Note 2: V_{DD} = 25 V, T_{ch} = 25°C (initial), L = 58 μ H, R_{G} = 25 Ω , I_{AR} = 45 A
- Note 3: Repetitive rating: pulse width limited by maximum junction temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.



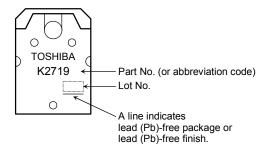
Electrical Characteristics (Ta = 25°C)

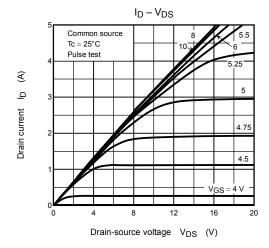
Chara	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS}=\pm30~V,~V_{DS}=0~V$	_	_	±10	μΑ
Gate-source breakdown voltage		V (BR) GSS	$I_G=\pm 10~\mu A,~V_{DS}=0~V$	±30	_	_	V
Drain cut-off current		I _{DSS}	$V_{DS} = 720 \text{ V}, V_{GS} = 0 \text{ V}$]	_	100	μΑ
Drain-source brea	akdown voltage	V (BR) DSS	$I_D = 10$ mA, $V_{GS} = 0$ V	900	_	_	V
Gate threshold voltage		V _{th}	V _{DS} = 10 V, I _D = 1 mA	2.0	_	4.0	V
Drain-source ON resistance		R _{DS (ON)}	V _{GS} = 10 V, I _D = 1.5 A	_	3.7	4.3	Ω
Forward transfer	admittance	Y _{fs}	V _{DS} = 20 V, I _D = 1.5 A	0.65	2.6	_	S
Input capacitance	•	C _{iss}		_	750	_	pF
Reverse transfer capacitance		C _{rss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz	_	10	_	pF
Output capacitance		C _{oss}		_	70	_	pF
Switching time	Rise time	t _r	$V_{GS} = 1.5 \text{ A} \\ V_{GS} = 1.5 \text{ A} \\ V_{OUT} = 1.5 \text{ A} \\ $	_	15	_	- ns
	Turn-on time	t _{on}			55	_	
	Fall time	t _f			30		
	Turn-off time	t _{off}		_	110	_	
Total gate charge (gate-source plus gate-drain)		Qg	V 400 V V 40 V I- 2 A	_	25		nC
Gate-source charge		Q _{gs}	$V_{DD} \simeq 400 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 3 \text{ A}$	_	13	_	nC
Gate-drain ("miller") charge		Q _{gd}		_	12	_	nC

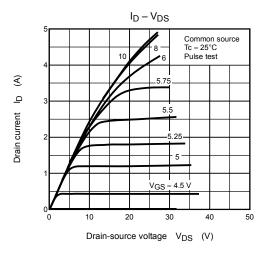
Source-Drain Diode Ratings and Characteristics (Ta = 25°C)

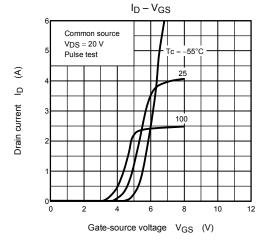
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	3	А
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	9	Α
Diode forward voltage	V_{DSF}	$I_{DR}=3~A,~V_{GS}=0~V$			-1.9	V
Reverse recovery time	t _{rr}	$I_{DR} = 3 A$, $V_{GS} = 0 V$		1100		ns
Reverse recovery charge	Q _{rr}	dl _{DR} /dt = 100 A/μs	_	7.5	_	μС

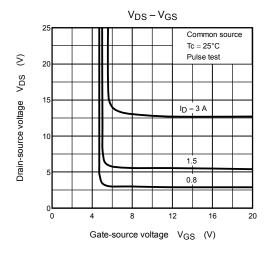
Marking

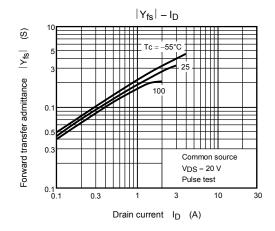


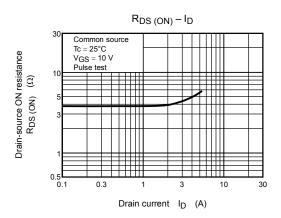


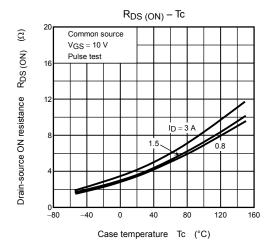


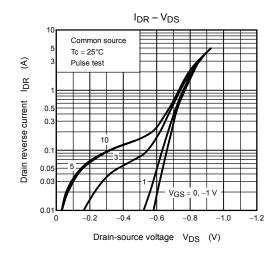


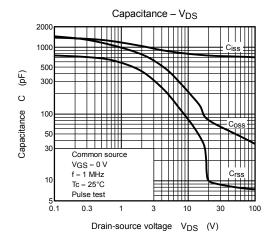


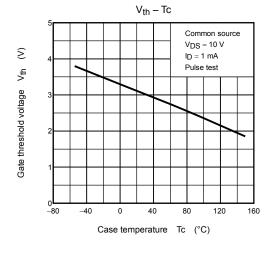


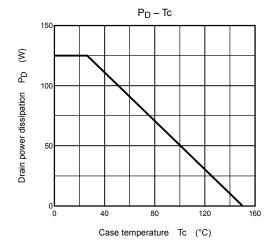


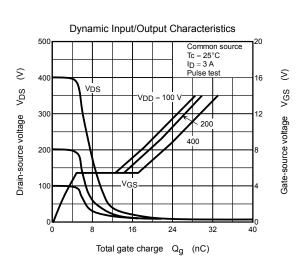




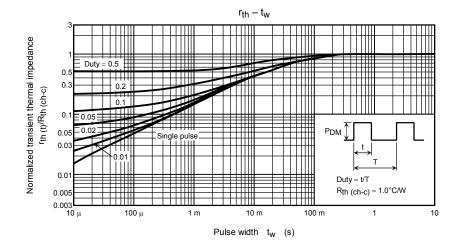


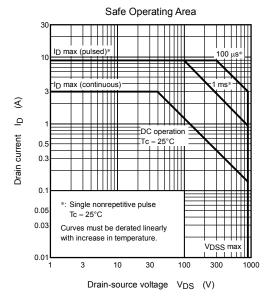


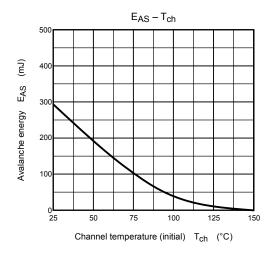


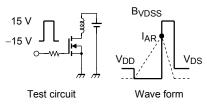


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$$\begin{aligned} R_G &= 25~\Omega \\ V_{DD} &= 90~V,~L = 60~mH \end{aligned}$$

$$E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right)$$

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